## Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

LEE ET AL.

Examiner

10764200

Art Unit

Wiehe, Nathan

3745

## **SEARCHED**

Class	Subclass	Date	Examiner
415	186,189,208.1,209,211.2,213.1,214.1	5/28/2007	NEW
416	244R	5/28/2007	NEW -

SEARCH NOTES						
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e	Date					

Search Notes			Date	Examiner
415/186,189,208.1,209,211.2,213.1,214.1	416/244R	Igor Kershteyn	5/28/2007	NEW
Text Search (See EAST Search History)			5/28/2007	NEW
Inventor Name Search			5/28/2007	NEW

	INTERFERENCE SEA	RCH	
Class	Subclass	Date	Examiner

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